



SLOVENSKI STANDARD SIST EN IEC 60352-3:2020

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Nespajkani spoji - 3. del: Dostopni izolacijsko prebodni spoji - Splošne zahteve, preskusne metode in praktični napotki (IEC 60352-3:2020)

Solderless connections - Part 3: Accessible insulation displacement (ID) connections - General requirements, test methods and practical guidance (IEC 60352-3:2020)

Lötfreie elektrische Verbindungen - Teil 3: Lötfreie zugängliche Schneidklemmverbindungen - Allgemeine Anforderungen, Prüfverfahren und Anwendungshinweise (IEC 60352-3:2020)

Connexions sans soudure - Partie 3: Connexions autodénudantes accessibles sans soudure - Règles générales, méthodes d'essai et guide pratique (IEC 60352-3:2020)

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EUROPEAN STANDARD

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NORME EUROPÉENNE

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May 2020

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Supersedes EN 60352-3:1994 and all of its amendments
and corrigenda (if any)

English Version

**Solderless connections - Part 3: Accessible insulation
displacement (ID) connections - General requirements, test
methods and practical guidance
(IEC 60352-3:2020)**

Connexions sans soudure - Partie 3: Connexions
autodénudantes accessibles sans soudure - Règles
générales, méthodes d'essai et guide pratique
(IEC 60352-3:2020)

Lötfreie elektrische Verbindungen - Teil 3: Lötfreie
zugängliche Schneidklemmverbindungen - Allgemeine
Anforderungen, Prüfverfahren und Anwendungshinweise
(IEC 60352-3:2020)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 60352-3:2020 (E)**European foreword**

The text of document 48B/2789/FDIS, future edition 2 of IEC 60352-3, prepared by SC 48B "Electrical connectors" of IEC/TC 48 "Electrical connectors and mechanical structures for electrical and electronic equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 60352-3:2020.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2021-02-14
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2023-05-14

This document supersedes EN 60352-3:1994 and all of its amendments and corrigenda (if any).

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The text of the International Standard IEC 60352-3:2020 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60352-4	NOTE	Harmonized as EN 60352-4
IEC 61984	NOTE	Harmonized as EN 61984

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-1	-	Environmental testing - Part 1: General and guidance	EN 60068-1	-
IEC 60228	-	Conductors of insulated cables	EN 60228	-
IEC 60512-1	-	Conductors of insulated cables	EN IEC 60512-1	-
IEC 60512-1-1	-	Connectors for electronic equipment - Tests and measurements - Part 1-1: General examination - Test 1a: Visual examination	EN 60512-1-1	-
IEC 60512-1-2	-	Connectors for electronic equipment - Tests and measurements - Part 1-2: General examination - Test 1b: Examination of dimension and mass	EN 60512-1-2	-
IEC 60512-2-1	-	Connectors for electronic equipment - Tests and measurements - Part 2-1: Electrical continuity and contact resistance tests - Test 2a: Contact resistance - Millivolt level method	EN 60512-2-1	-
IEC 60512-2-2	-	Connectors for electronic equipment - Tests and measurements - Part 2-2: Electrical continuity and contact resistance tests - Test 2b: Contact resistance - Specified test current method	EN 60512-2-2	-
IEC 60512-2-5	-	Connectors for electronic equipment - Tests and measurements - Part 2-5: Electrical continuity and contact resistance tests - Test 2e: Contact disturbance	EN 60512-2-5	-

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IEC 60512-6-4	-	Connectors for electronic equipment - Tests and measurements - Part 6-4: Dynamic stress tests - Test 6d: Vibration (sinusoidal)	EN 60512-6-4	-
IEC 60512-9-2	-	Connectors for electronic equipment - Tests and measurements - Part 9-2: Endurance tests - Test 9b: Electrical load and temperature	EN 60512-9-2	-
IEC 60512-11-1	-	Connectors for electrical and electronic equipment - Tests and measurements - Part 11-1: Climatic tests - Test 11a - Climatic sequence	EN IEC 60512-11-1	-
IEC 60512-11-4	-	Connectors for electronic equipment - Tests and measurements - Part 11-4: Climatic tests - Test 11d: Rapid change of temperature	EN 60512-11-4	-
IEC 60512-11-7	-	Connectors for electronic equipment - Tests and measurements - Part 11-7: Climatic tests - Test 11g: Flowing mixed gas corrosion test	EN 60512-11-7	-
IEC 60512-11-9	-	Connectors for electronic equipment - Tests and measurements - Part 11-9: Climatic tests - Test 11i: Dry heat	EN 60512-11-9	-
IEC 60512-11-10	-	Connectors for electronic equipment - Tests and measurements - Part 11-10: Climatic tests - Test 11j: Cold	EN 60512-11-10	-
IEC 60512-11-12	-	Connectors for electronic equipment - Tests and measurements - Part 11-12: Climatic tests - Test 11m: Damp heat, cyclic	EN 60512-11-12	-



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INTERNATIONAL STANDARD

NORME INTERNATIONALE

Solderless connections –
Part 3: Accessible insulation displacement (ID) connections – General requirements, test methods and practical guidance

Connexions sans soudure –
Partie 3: Connexions autodénudantes accessibles – Règles générales, méthodes d'essai et guide pratique

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

SOLDERLESS CONNECTIONS –**Part 3: Accessible insulation displacement (ID) connections –
General requirements, test methods and practical guidance**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 60352-3 has been prepared by subcommittee 48B: Electrical connectors, of IEC technical committee 48: Electrical connectors and mechanical structures for electrical and electronic equipment.

This second edition cancels and replaces the first edition published in 1993. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Subclause 7.2.2: reduce the limit of duration of contact disturbance to 1 μ s.
- b) Subclause 7.2.3: reduce the limit of duration of contact disturbance to 1 μ s.
- c) Transferred Clauses 9 to 13 to Annex A (informative).
- d) The figures were revised for clarity.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
48B/2789/FDIS	48B/2802/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60352 series, published under the general title *Solderless connections*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

The two following parts of IEC 60352 are available on solderless insulation displacement connections:

- Part 3: Accessible insulation displacement connections – General requirements, test methods and practical guidance;
- Part 4: Solderless non-accessible insulation displacement connections – General requirements, test methods and practical guidance.

NOTE In this document the term "insulation displacement" is abbreviated to "ID", for example "ID connection", "ID termination".

Figure 1 illustrates examples of accessible and non-accessible insulation displacement connections that clarify the difference among them.

Part 3 includes requirements and relevant tests (normative) as well as a practical guidance in Annex A (informative) for accessible ID connections.

Two test schedules are provided:

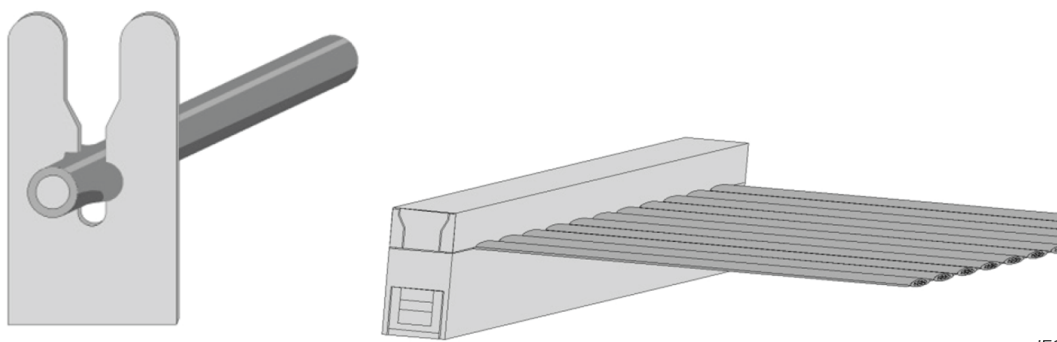
- the basic test schedule which applies to insulation displacement connections which conform to all prerequisites of Clause 5. It is derived from experience with successful applications of such connections;
- the full test schedule which applies to insulation displacement connections which do not fully conform to all prerequisites of Clause 5, for example which are manufactured using materials or finishes not included in Clause 5.

This philosophy permits cost and time effective performance verification using a limited basic test schedule for established insulation displacement connections and an expanded full test schedule for connections requiring more extensive performance validation.

The suitability of the accessible ID connection implies that the specified requirements and tests apply to all factors involved in producing a suitable ID connection, namely:

- the accessible ID termination, which may be part of a single-pole or multipole connector;
- the wire (or range of wires) for which the termination is suitable;
- the tools (if any) required to produce that type of solderless connection.

The practical guidance (informative Annex A) serves as a guideline for the required workmanship. Attention is drawn to the fact that some industries (e.g. automotive, aerospace, nuclear, military) may have specific workmanship standards and/or quality requirements, which are outside the scope of this standard.



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Figure 1 – Example of accessible and non-accessible insulation displacement connection